

<b>Notice of References Cited</b>	Application/Control No. 09/890,688	Applicant(s)/Patent Under Reexamination KATO ET AL.	
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	U	Maddock et al. (J of Bacteriology (1997) 179(20): 6426-6431)
	V	Lin et al. (J of Bacteriology (1999) 181(18): 5825-5832)
	W	Lin et al. (FEBS Letters (2000) 484(1): 29-32)
	X	Lin et al. (Molecular Microbiology (2001) 39(4): 924-934)

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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